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Application/Control No.	Applicant(s)/Patent under Reexamination
10/712,577	MORISHIMA ET AL.
Examiner	Art Unit
Linh T. Nguyen	2627

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC	IOTES CH STRATEGY)
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East Searched.	6/23/2006	LN
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